Applicant(s)/Patent Under Application/Control No. Reexamination 10/603,509 FRICK, ROMAN Notice of References Cited Examiner Art Unit Page 1 of 1 3632 Tan Le **U.S. PATENT DOCUMENTS** Date Document Number Name Classification Country Code-Number-Kind Code MM-YYYY US-2002/0185583 248/676 12-2002 Metelski, Andrzej Α Metelski, Andrzej 248/676 В US-6,679,470 01-2004 248/415 С US-6,871,828 03-2005 Frick et al. D US-Ε US-F US-US-G US-Н US-1 J US-Κ US-US-US-FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

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